

1. Description

The BLM055N04 uses advanced trench technology to provide excellent RDS(ON), low gate charge. It can be used in a wide variety of applications.

KEY CHARACTERISTICS

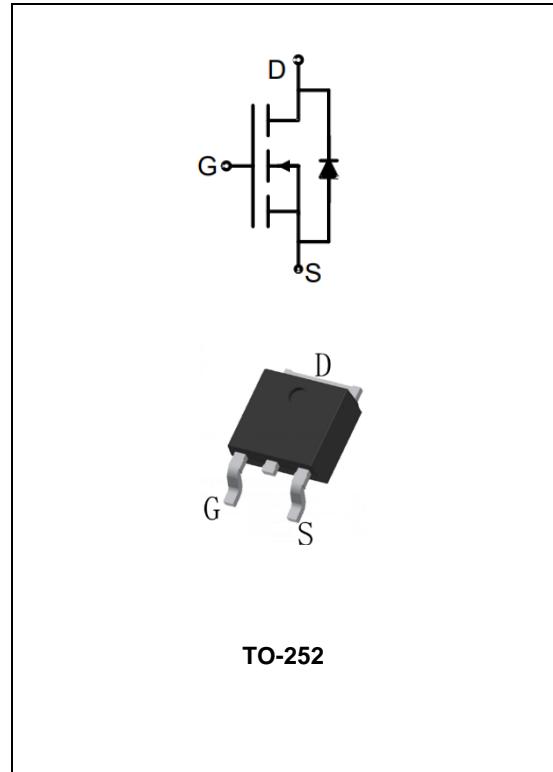
Parameter	Value	Unit
V _{DS}	40	V
I _D	80	A
R _{DS(ON)} @ 10V _{.Typ}	3.4	mΩ
R _{DS(ON)} @ 4.5V _{.Typ}	4.5	mΩ

FEATURES

- Advanced Trench Technology
- Excellent RDS(ON) and Low Gate Charge
- LeadFree

APPLICATIONS

- LoadSwitch
- PWM Application
- Power Management

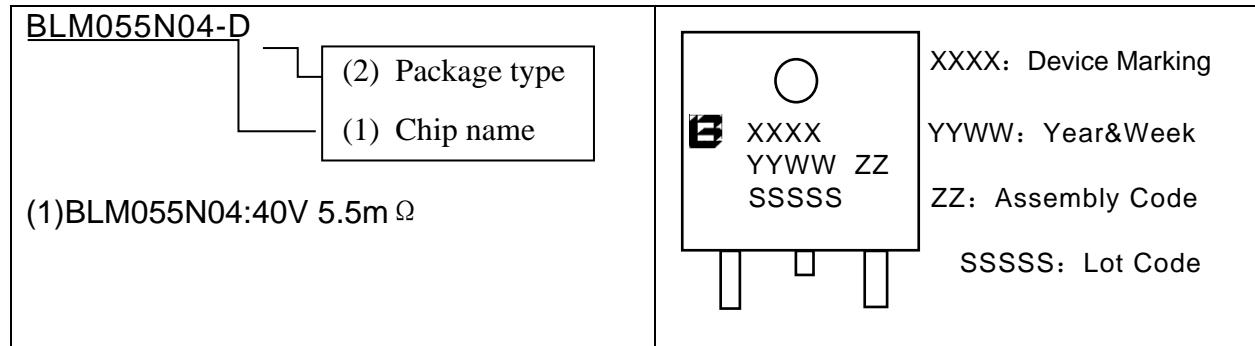


100% UIS TESTED!

100% ΔVds TESTED!

ORDERING INFORMATION

Device Marking	Ordering Codes	Package	Product Code	Packing
M055N04	BLM055N04-D	TO-252	BLM055N04	Reel



2. ABSOLUTE RATINGS

at $T_C = 25^\circ\text{C}$, unless otherwise specified

Symbol	Parameter	Rating	Units
V_{DSS}	Drain-to-Source Voltage	40	V
I_D	Continuous Drain Current	80	A
$I_{DM}(\text{Note1})$	Pulsed Drain Current	320	A
P_D	Power Dissipation	64.1	W
V_{GS}	Gate-to-Source Voltage	± 20	V
E_{AS}	Single Pulse Avalanche Energy(Note2)	110.3	mJ
T_J, T_{stg}	Operating Junction and Storage Temperature Range	-55 to 150	$^\circ\text{C}$

3. Thermal characteristics

Symbol	Parameter	RATINGS	Units
R_{eJC}	Junction-to- Case	1.95	$^\circ\text{C}/\text{W}$

4. Electrical Characteristics

at $T_C = 25^\circ\text{C}$, unless otherwise specified

OFF Characteristics						
Symbol	Parameter	Test Conditions	Values			Units
			Min.	Typ.	Max.	
V_{DSS}	Drain to Source Breakdown Voltage	$V_{GS}=0\text{V}, I_D=250\mu\text{A}$	40	--	--	V
I_{DSS}	Drain to Source Leakage Current	$V_{DS} = 40\text{V}, V_{GS} = 0\text{V}$	--	--	1	μA
I_{GSS}	Gate to Source Forward Leakage	$V_{GS} = \pm 20\text{V}$	--	--	100	nA

ON Characteristics						
Symbol	Parameter	Test Conditions	Values			Units
			Min.	Typ.	Max.	
$R_{DS(ON)}$ (Note3)	Drain-to-Source On-Resistance	$V_{GS}=10\text{V}, I_D=30\text{A},$	--	3.4	5.5	$\text{m}\Omega$
		$V_{GS}=4.5\text{V}, I_D=20\text{A},$	--	4.5	10	
$V_{GS(TH)}$	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_D = 250\mu\text{A}(\text{Note2})$	1	1.5	2.5	V

Dynamic Characteristics

Symbol	Parameter	Test Conditions	Values			Units
			Min.	Typ.	Max.	
C _{iss}	Input Capacitance	VGS = 0V VDS = 15V f = 1.0MHz	--	2241	--	pF
C _{oss}	Output Capacitance		--	160	--	
C _{rss}	Reverse Transfer Capacitance		--	149	--	

Switching Characteristics

Symbol	Parameter	Test Conditions	Values			Units
			Min.	Typ.	Max.	
t _{d(ON)}	Turn-on Delay Time	VDD = 20V ID=2A RL =1Ω RGEN =3Ω VGS = 10V	--	8	--	ns
t _r	Rise Time		--	18	--	
t _{d(OFF)}	Turn-Off Delay Time		--	24	--	
t _f	Fall Time		--	14	--	
Q _g	Total Gate Charge	ID =40A VDD =10V VGS = 10V	--	80.4	--	nC
Q _{gd}	Gate to Drain ("Miller")Charge		--	11.2	--	
Q _{gs}	Gate to Source Charge		--	15	--	

Source-Drain Diode Characteristics

Symbol	Parameter	Test Conditions	Values			Units
			Min.	Typ.	Max.	
I _s	Continuous Source Current (Body Diode)	T _C =25 °C	--	--	80	A
V _{SD}	Diode Forward Voltage	I _S =20A, V _{GS} =0V(Note2)	--	--	1.2	V

Note1: Pulse width limited by maximum junction temperature

Note2: Eas condition: T_j=25°C, V_G=10V,L=0.5mH,I_{AS}=21A

Note3: Pulse width t_p≤300μs, δ ≤2%

5. Characteristics Curves

Figure 1 Output Characteristics

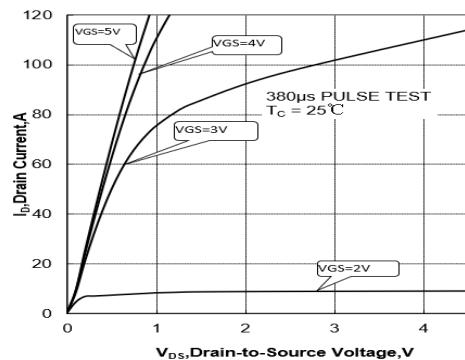


Figure 2 Transfer Characteristics

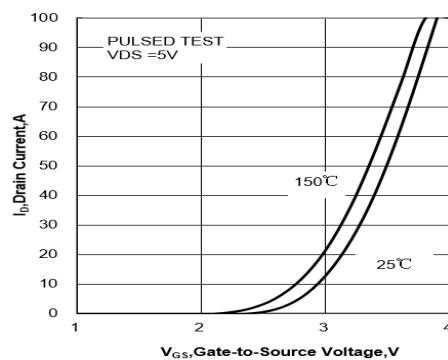


Figure 3 On-Resistance vs. I_D

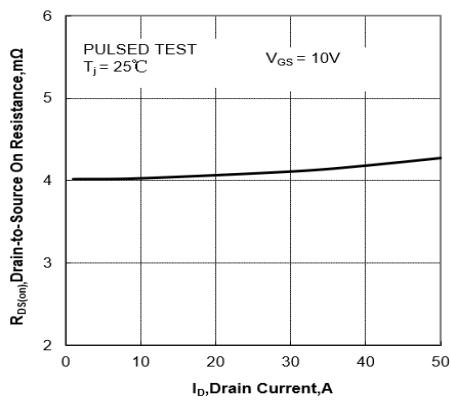


Figure 4 On-Resistance vs. Junction Temperature

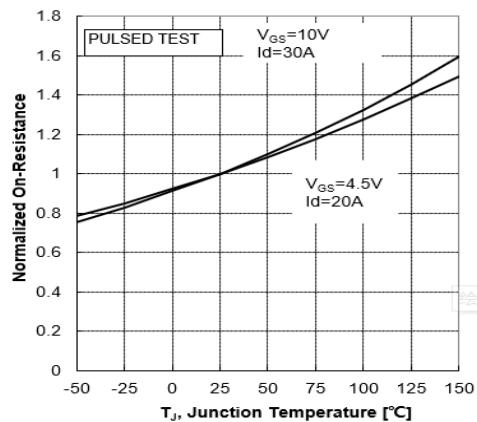


Figure 5 BV vs Junction Temperature

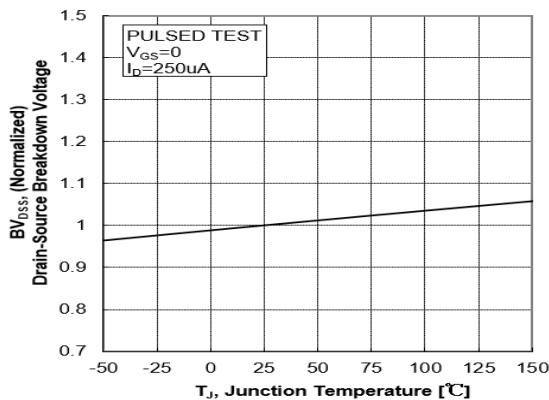


Figure 6 Vth vs Junction Temperature

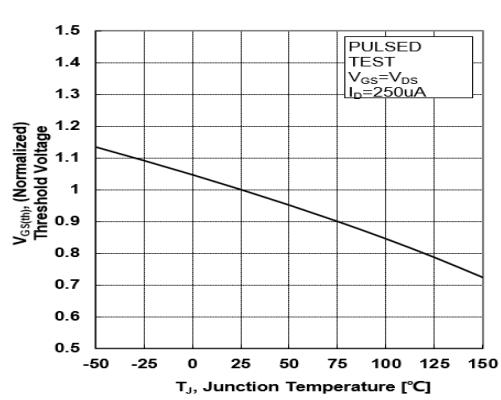
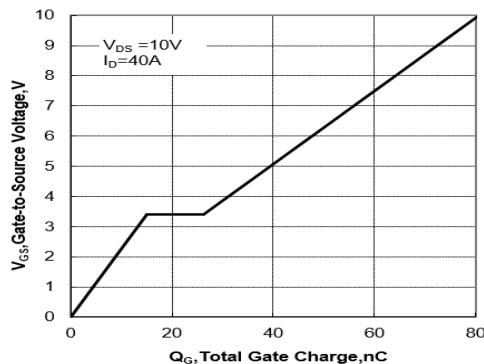
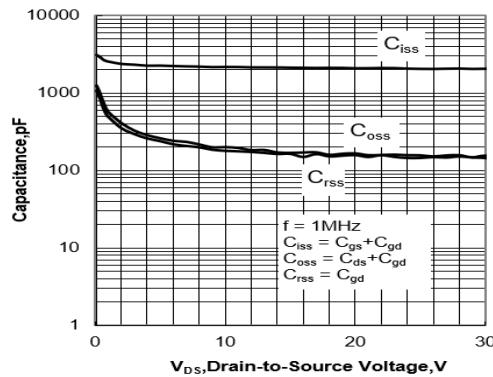
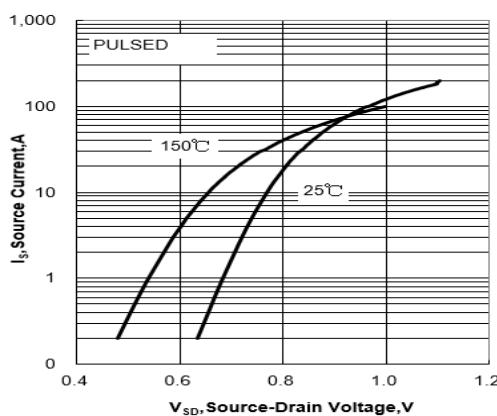
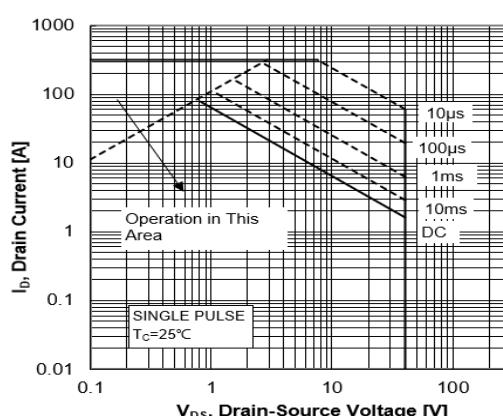
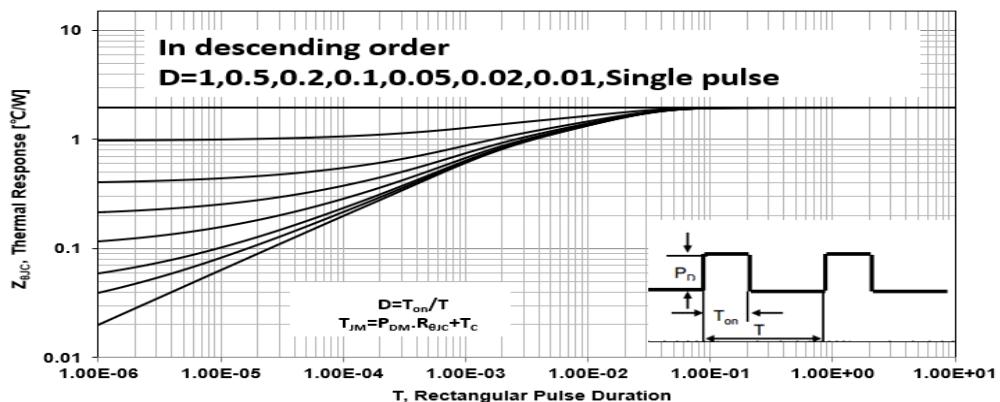
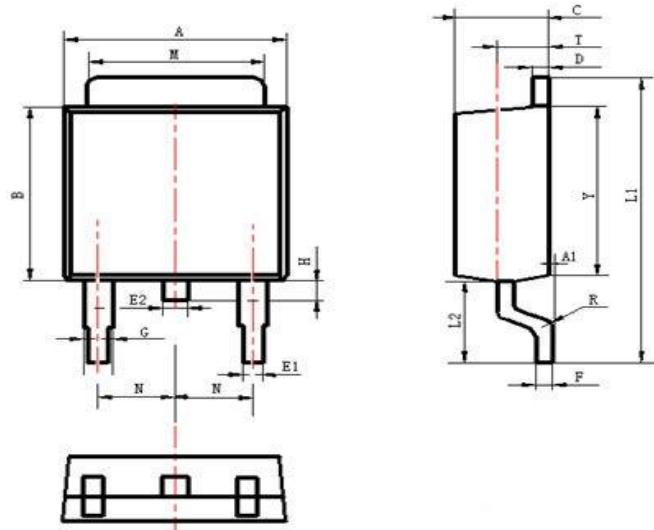


Figure 7 Gate-Charge Characteristics

Figure 8 Capacitance Characteristics

Figure 9 Body Diode Forward Voltage

Figure 10 Maximum Safe Operating Area

Figure 11 Transient Thermal Impedance


Package Description



Items	Values(mm)	
	MIN	MAX
A	6.30	6.90
A1	0	0.13
B	5.70	6.30
C	2.10	2.50
D	0.30	0.60
E1	0.60	0.90
E2	0.70	1.00
F	0.30	0.60
G	0.70	1.20
L1	9.60	10.50
L2	2.70	3.10
H	0.60	1.00
M	5.10	5.50
N	2.09	2.49
R	0 .3	
T	1.40	1.60
Y	5.10	6.30

TO-252 Package

NOTE:

1. Exceeding the maximum ratings of the device in performance may cause damage to the device, even the permanent failure, which may affect the dependability of the machine. Please do not exceed the absolute maximum ratings of the device when circuit designing.
2. When installing the heat sink, please pay attention to the torsional moment and the smoothness of the heat sink.
3. MOSFETs is the device which is sensitive to the static electricity, it is necessary to protect the device from being damaged by the static electricity when using it.
4. Shanghai Belling reserves the right to make changes in this specification sheet and is subject to change without prior notice.

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